

Abstract Submitted
for the MAR10 Meeting of
The American Physical Society

Theoretical investigation of the InN/In₂O₃ interface GIANCARLO CICCERO, ANTONIO ALIANO, Materials Science and Chemical Eng. Dep., Politecnico of Torino, Italy, ALESSANDRA CATELLANI, CNR-IMEM, Parma, Italy, NANOLICHT COLLABORATION — Indium Nitrides (InN) nanowires (NWs) have attracted lot of attention because of their potential applications in optoelectronics and solar cells. Recent XPS measurements on collections of InN NWs showed that a thin amorphous oxide layer (In₂O₃) at the InN NW surface is formed upon exposure to air, altering the electronic properties of the NWs [1]. A deep understanding of the electronic properties of amorphous In₂O₃ and of the InN/In₂O₃ interface assume great relevance in the clarification on the NWs electronic properties and it can shed light on the surface contribution to their conductivity. Motivated by this experimental evidence, we have undertaken a combined classical and ab initio theoretical investigation of amorphous In₂O₃ and of a realistic In₂O₃/InN interface. Here we discuss the properties of these systems evidencing the difference and similarities between the In₂O₃ amorphous and crystalline structure first and then presenting how the level alignment at the In₂O₃/InN heterostructure may affect InN NWs features. [1] F. Werner et al., Nano Letters 9, 1567 (2009)

Giancarlo Cicero
Materials Science and Chemical Eng. Dep., Politecnico of Torino, Italy

Date submitted: 01 Dec 2009

Electronic form version 1.4